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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/775,589	ONO ET AL.	
Examiner	Art Unit	
Picholo I Hanov	2765	

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Class	Subclass	Date	Examiner
above	updated	7/20/2006	RLH
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	earch history	7/20/2006	RLH

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
See EAST claim printout	7/20/2006	RLH	
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